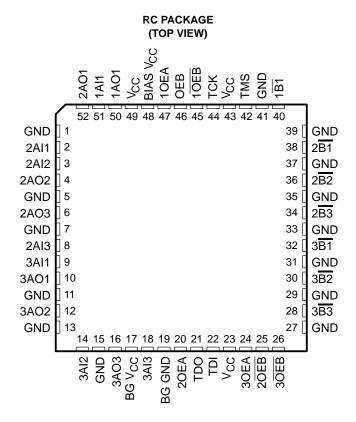
- Compatible With IEEE Std 1194.1-1991 (BTL)
- TTL A Port, Backplane Transceiver Logic (BTL) B Port
- Open-Collector B-Port Outputs Sink 100 mA
- BIAS V_{CC} Pin Minimizes Signal Distortion **During Live Insertion or Withdrawal**
- **High-Impedance State During Power Up** and Power Down
- **B-Port Biasing Network Preconditions the** Connector and PC Trace to the BTL **High-Level Voltage**
- **TTL-Input Structures Incorporate Active** Clamping to Aid in Line Termination



description

The SN74FB2041A is a 7-bit transceiver designed to translate signals between TTL and backplane transceiver logic (BTL) environments. The device is specifically designed to be compatible with IEEE Std 1194.1-1991.

The B port operates at BTL signal levels. The open-collector B ports are specified to sink 100 mA. Two output enables (OEB and OEB) are provided for the B outputs. When OEB is high and OEB is low, the B port is active and reflects the inverse of the data present at the A-input pins. When OEB is low, $\overline{\text{OEB}}$ is high, or V_{CC} is less than 2.1 V, the B port is turned off. The enable/disable logic partitions the device as two 3-bit sections and one 1-bit section.

The A port operates at TTL signal levels and has split input and output pins. The A outputs reflect the inverse of the data at the B port when the A-port output enable (OEA) is high. When OEA is low or when V_{CC} is less than 2.1 V, the A outputs are in the high-impedance state.



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SCBS172M - NOVEMBER 1991 - REVISED MARCH 2002

description (continued)

The pins TMS, TCK, TDI, and TDO are nonfunctional, i.e., not intended for use with the IEEE Std 1149.1 (JTAG) test bus. TMS and TCK are not connected and TDI is shorted to TDO.

BIAS V_{CC} establishes a voltage between 1.62 V and 2.1 V on the BTL outputs when V_{CC} is not connected.

ORDERING INFORMATION

| TA | PACKAGE† | | | TOP-SIDE MARKING | |
|-------------|----------|------|---------------|---------------------|--|
| 0°C to 70°C | QFP – RC | Tube | SN74FB2041ARC | FB2041A | |

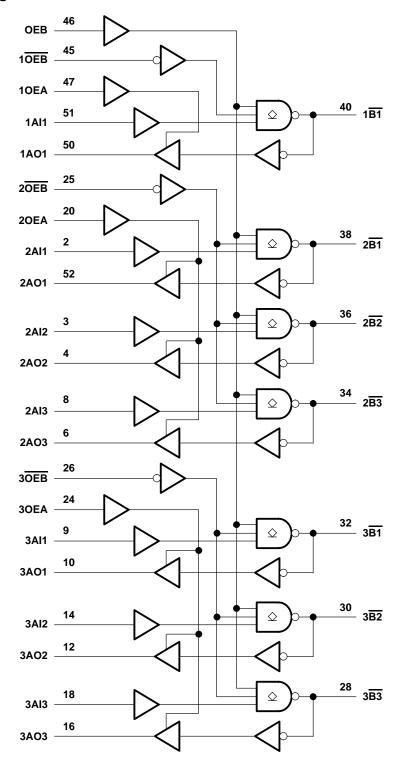
[†] Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

FUNCTION TABLE

| | INPUTS | | FUNCTION | | | | |
|-----|--------|-----|--|--|--|--|--|
| OEB | OEB | OEA | FUNCTION | | | | |
| L | Χ | L | Isolation | | | | |
| Х | Н | L | Isolation | | | | |
| L | Х | Н | = | | | | |
| Х | Н | Н | B data to AO bus | | | | |
| Н | L | L | Al data to B bus | | | | |
| Н | L | Н | \overline{AI} data to B bus, \overline{B} data to AO bus | | | | |



functional block diagram





SCBS172M - NOVEMBER 1991 - REVISED MARCH 2002

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

| Supply voltage range, V _{CC} | \dots –0.5 V to 7 V |
|--|--|
| Input voltage range, V _I : Except B port | |
| B port | -1.2 V to 3.5 V |
| Voltage range applied to any \overline{B} output in the disabled or power-off state, V_0 | –0.5 V to 3.5 V |
| Voltage range applied to any output in the high state, VO: A port | \dots -0.5 V to V _{CC} |
| Input clamp current, I _{IK} : Except \overline{B} port | –40 mA |
| B port | –18 mA |
| Current applied to any single output in the low state, IO: A port | 48 mA |
| B port | 200 mA |
| Package thermal impedance, θ _{JA} (see Note 1) | 44°C/W |
| Storage temperature range, T _{stq} | . -65°C to 150°C |

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions (see Note 2)

| | | | MIN | NOM | MAX | UNIT | |
|---|---|---------------|------|-----|------|------|--|
| V _{CC} , BIAS V _{CC} , BG V _{CC} | CC, AS V _{CC} , Supply voltage 5 V _{CC} | | 4.5 | 5 | 5.5 | V | |
| \/ | High level input voltage | B port | 1.62 | | 2.3 | \/ | |
| VIH | High-level input voltage | Except B port | 2 | | | V | |
| Mar | | B port | 0.75 | | 1.47 | 7 , | |
| VIL | Low-level input voltage | Except B port | | | 8.0 | V | |
| lıK | I _{IK} Input clamp current | | | | -18 | mA | |
| I _{ОН} | High-level output current | AO port | | | -3 | mA | |
| la. | Law lavel autout aument | AO port | | | 24 | A | |
| lor | Low-level output current B port | | | | 100 | mA | |
| TA | Operating free-air temperature | _ | 0 | | 70 | °C | |

NOTE 2: To ensure proper device operation, all unused inputs must be terminated as follows: A and control inputs to V_{CC}(5 V) or GND, and B inputs to GND only. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.



NOTE 1: The package thermal impedance is calculated in accordance with JESD 51-7.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER | | TEST | TEST CONDITIONS | | | MAX | UNIT | |
|-------------------|----------------------|---|---|------|------|------|------|--|
| Viva | B port | V _{CC} = 4.5 V, | I _I = -18 mA | | | -1.2 | V | |
| VIK | Except B port | V _{CC} = 4.5 V, | I _I = -40 mA | | | -0.5 | V | |
| Vон | AO port | V _{CC} = 4.5 V, | I _{OH} = –3 mA | 2.5 | 3.3 | | V | |
| | AO port | V _{CC} = 4.5 V, | I _{OL} = 24 mA | | 0.35 | 0.5 | | |
| VOL | <u> </u> | Voc - 45 V | $I_{OL} = 80 \text{ mA}$ | 0.75 | | 1.1 | V | |
| | B port | V _{CC} = 4.5 V | I _{OL} = 100 mA | | | 1.15 | | |
| lį | Except B port | $V_{CC} = 5.5 \text{ V},$ | V _I = 5.5 V | | | 50 | μΑ | |
| I _{IH} ‡ | Except B port | V _{CC} = 5.5 V, | V _I = 2.7 V | | | 50 | μΑ | |
| . + | Except B port | V _{CC} = 5.5 V, | V _I = 0.5 V | | | -50 | | |
| I _{IL} ‡ | B port | V _{CC} = 5.5 V, | V _I = 0.75 V | | | -100 | μΑ | |
| ІОН | B port | $V_{CC} = 0 \text{ to } 5.5 \text{ V},$ | V _O = 2.1 V | | | 100 | μΑ | |
| lozh | AO port | V _{CC} = 5.5 V, | V _O = 2.7 V | | | 50 | μΑ | |
| lozL | AO port | V _{CC} = 5.5 V, | V _O = 0.5 V | | | -50 | μΑ | |
| lozpu | AO port | $V_{CC} = 0 \text{ to } 2.1 \text{ V},$ | $V_0 = 0.5 \text{ V to } 2.7 \text{ V}$ | | | 50 | μΑ | |
| lozpd | AO port | $V_{CC} = 2.1 \text{ V to } 0,$ | $V_0 = 0.5 \text{ V to } 2.7 \text{ V}$ | | | -50 | μΑ | |
| los§ | AO port | V _{CC} = 5.5 V, | V _O = 0 | -30 | | -180 | mA | |
| | Al port to B port | V 55V | | | | 45 | Δ | |
| ICC | B port to AO port | $V_{CC} = 5.5 \text{ V},$ | IO = 0 | | | 65 | mA | |
| 0 | Al port | V 05V = 05V | | 3 | | | | |
| Ci | Control inputs | V _I = 0.5 V or 2.5 V | | 3 | | pF | | |
| Со | AO port | V _O = 0.5 V or 2.5 V | | | 5.5 | | pF | |
| | B port per | V _{CC} = 0 to 4.5 V | | | | 5 | pF | |
| C _{io} | IEEE Std 1194.1-1991 | V _{CC} = 4.5 V to 5.5 V | V _{CC} = 4.5 V to 5.5 V | | | 5 | | |

live-insertion specifications over recommended operating free-air temperature range

| PAR | AMETER | TEST CONDITIONS | | | MIN | MAX | UNIT |
|---|--------|--|--|---|------|-----|------|
| I _{CC} (BIAS V _{CC}) | | V _{CC} = 0 to 4.5 V | $V_B = 0 \text{ to } 2 \text{ V},$ $V_I \text{ (BIAS V}_{CC}) = 4.5 \text{ V to } 5.5 \text{ V}$ | | | 450 | μA |
| | | $V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$ | | | | 10 | μΑ |
| VO | B port | $V_{CC} = 0$, | V _I (BIAS V _{CC}) = 5 V | | 1.62 | 2.1 | V |
| | | $V_{CC} = 0$, | $V_{B} = 1 V,$ | V_{I} (BIAS V_{CC}) = 4.5 V to 5.5 V | -1 | | |
| IO B port | | $V_{CC} = 0 \text{ to } 5.5 \text{ V},$ | OEB = 0 to 0.8 V | | | 100 | μΑ |
| | | V _{CC} = 0 to 2.2 V, | OEB = 0 to 5 V | | | 100 | |

[†] All typical values are at V_{CC} = 5 V, T_A = 25°C. ‡ For I/O ports, the parameters I_{IH} and I_{IL} include the off-state output current. § Not more than one output should be shorted at a time, and the duration of the short circuit should not exceed one second.

SCBS172M - NOVEMBER 1991 - REVISED MARCH 2002

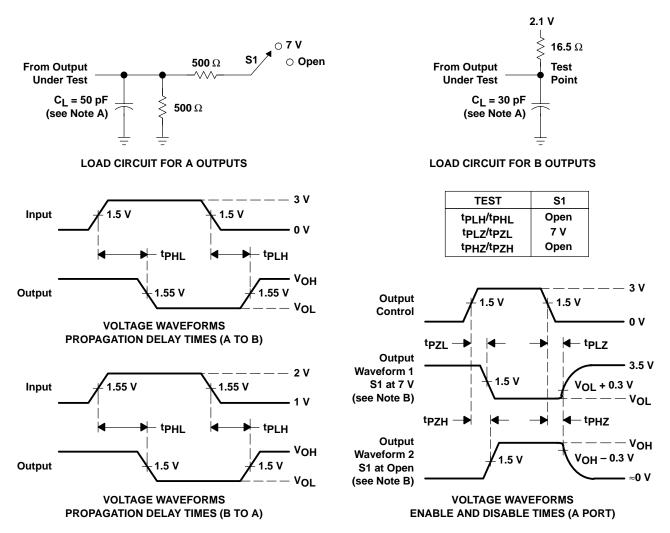
switching characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 1)

| PARAMETER | FROM (INPUT) | TO (OUTPUT) | V _{CC} = 5 V, T _A = 25°C | | | MIN | MAX | UNIT |
|----------------------|--------------------------------------|-------------------|---|-----|-----|-----|-----|------|
| | (1141 01) | (0011 01) | MIN | TYP | MAX | | | |
| ^t PLH | Al | - B | 2.3 | 3.9 | 5.1 | 2 | 5.6 | ns |
| ^t PHL | Al | В | 2.6 | 4.1 | 5 | 2.5 | 5.3 | 115 |
| ^t PLH | В | AO | 2 | 3.6 | 4.8 | 1.7 | 5.3 | ns |
| ^t PHL | В | AO | 2.3 | 3.8 | 4.9 | 2 | 6.4 | 115 |
| ^t PLH | OEB | B | 3 | 4.6 | 5.8 | 2.6 | 6.3 | ns |
| tPHL | OEB | В | 3.1 | 4.7 | 6 | 3.1 | 6.2 | 115 |
| ^t PLH | OEB | - B | 2.7 | 4.3 | 5.6 | 2.6 | 5.8 | 20 |
| t _{PHL} | | В | 2.7 | 4.2 | 5.3 | 2.5 | 6.4 | ns |
| ^t PZH | 054 | OEA AO | 1.5 | 3.2 | 5.2 | 1.5 | 5.2 | ns |
| ^t PZL | OLA | | 1.1 | 2.8 | 5 | 1 | 5 | 115 |
| ^t PHZ | OEA | AO | 1 | 2.4 | 3.9 | 1 | 4.2 | ns |
| tPLZ | OEA | AO | 2.2 | 3.8 | 5.6 | 1.7 | 5.8 | 115 |
| t _{sk(p)} † | Pulse skew, Al to B or B to AO | | | 0.5 | | | | ns |
| t _{sk(o)} † | Output skew, Al to B or B to AO | | | 0.4 | | | | ns |
| t _t | Rise time, 1.3 V to 1.8 V, B outputs | | 1 | 1.6 | 2.4 | 1 | 2.5 | |
| | Fall time, 1.8 V to 1.3 V, B out | tputs | 1 | 1.4 | 2.3 | 1 | 2.4 | ns |
| ^t (pr) | B-port input pulse rejection | | 1 | | | 1 | | ns |

[†] Skew values are applicable for through mode only.



PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: TTL inputs: PRR \leq 10 MHz, Z_O = 50 Ω , $t_f \leq$ 2.5 ns, $t_f \leq$ 2.5 ns, $t_f \leq$ 2.5 ns.
- D. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuits and Voltage Waveforms

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